

AOD442G 60V N-Channel MOSFET

General Description

- Trench Power MV MOSFET technology
- Low R_{DS(ON)}
- Logic Level Driving
- RoHS and Halogen-Free Compliant

Product Summary

 $\begin{array}{lll} V_{DS} & 60V \\ I_{D} \; (at \, V_{GS} \! = \! 10V) & 40A \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 10V) & < 18 m\Omega \\ R_{DS(ON)} \; (at \, V_{GS} \! = \! 4.5V) & < 23 m\Omega \end{array}$

Applications

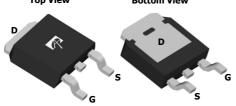
• Industrial and Motor Drive applications

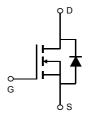
100% UIS Tested 100% Rg Tested



TO252 DPAK







Orderable Part Number	Package Type	Form	Minimum Order Quantity
AOD442G	TO-252	Tape & Reel	2500

Absolute Maximum Ratings	T _A =25°C unless	otherwise n	oted

Parameter		Symbol	Maximum	Units
Drain-Source Voltage		V _{DS}	60	V
Gate-Source Voltage		V _{GS}	±20	V
Continuous Drain	T _C =25°C		40	
Current	T _C =100°C	I _D	25.5	A
Pulsed Drain Currer	nt ^C	I _{DM}	90	
Continuous Drain	T _A =25°C		13	^
Current	T _A =70°C	IDSM	10.5	A
Avalanche Current C		I _{AS}	30	A
Avalanche energy	L=0.1mH	E _{AS}	45	mJ
	T _C =25°C	В	60	10/
Power Dissipation ^B	T _C =100°C	$-P_{D}$	24	W
	T _A =25°C	В	6.2	W
Power Dissipation A	T _A =70°C	P _{DSM}	4.0	VV
Junction and Storage Temperature Range		T _J , T _{STG}	-55 to 150	°C

Thermal Characteristics					
Parameter		Symbol	ol Typ Max		Units
Maximum Junction-to-Ambient A	t ≤ 10s	D	15	20	°C/W
Maximum Junction-to-Ambient AD	Steady-State	$R_{\theta JA}$	40	50	°C/W
Maximum Junction-to-Case	Steady-State	$R_{\theta JC}$	1.7	2.1	°C/W



Electrical Characteristics (T_J=25°C unless otherwise noted)

Symbol	Parameter	Conditions		Min	Тур	Max	Units
STATIC F	PARAMETERS						
BV _{DSS}	Drain-Source Breakdown Voltage	I _D =250μA, V _{GS} =0V		60			V
I _{DSS}	Zero Gate Voltage Drain Current	V _{DS} =60V, V _{GS} =0V				1	μA
iDSS	Zelo Gate Voltage Dialii Culient		T _J =55°C			5	μΑ
I_{GSS}	Gate-Body leakage current	V _{DS} =0V, V _{GS} =±20V				±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	$V_{DS}=V_{GS}$, $I_{D}=250\mu A$		1.5	2.1	2.7	V
		V_{GS} =10V, I_D =20A			14	18	mΩ
$R_{DS(ON)}$	Static Drain-Source On-Resistance		T _J =125°C		24.5	32	11177
		V_{GS} =4.5V, I_D =20A			17	23	mΩ
g _{FS}	Forward Transconductance	V_{DS} =5V, I_D =20A			62		S
V_{SD}	Diode Forward Voltage	I _S =1A, V _{GS} =0V			0.7	1	V
Is	Maximum Body-Diode Continuous Cur	rent			40	Α	
DYNAMIC	PARAMETERS						
C _{iss}	Input Capacitance				1920		pF
Coss	Output Capacitance	V _{GS} =0V, V _{DS} =30V, f=1MHz f=1MHz			155		pF
C _{rss}	Reverse Transfer Capacitance				115		pF
R_g	Gate resistance			0.3	0.65	1.1	Ω
SWITCHI	NG PARAMETERS	•			•	•	•
Q _g (10V)	Total Gate Charge	-V _{GS} =10V, V _{DS} =30V, I _D =20A			47.5	68	nC
Q _g (4.5V)	Total Gate Charge				24	35	nC
Q_{gs}	Gate Source Charge				6		nC
Q_{gd}	Gate Drain Charge				14.5		nC
Q _{oss}	Output Charge	V_{GS} =0V, V_{DS} =30V	V _{GS} =0V, V _{DS} =30V		8		nC
t _{D(on)}	Turn-On DelayTime				8		ns
t _r	Turn-On Rise Time	V_{GS} =10V, V_{DS} =30V, R_{L} =1.5 Ω , R_{GEN} =3 Ω			5		ns
t _{D(off)}	Turn-Off DelayTime				30		ns
t _f	Turn-Off Fall Time				5.5		ns
t _{rr}	Body Diode Reverse Recovery Time	I _F =20A, di/dt=500A/μs			30		ns
Q _{rr}	Body Diode Reverse Recovery Charge	_e I _F =20A, di/dt=500A/μ	I _F =20A, di/dt=500A/μs		105		nC

A. The value of R_{BJA} is measured with the device mounted on 1in² FR-4 board with 2oz. Copper, in a still air environment with T_A =25° C. The Power dissipation P_{DSM} is based on R _{8JA} t≤ 10s and the maximum allowed junction temperature of 150° C. The value in any given application depends on the user's specific board design.

APPLICATIONS OR USE AS CRITICAL COMPONENTS IN LIFE SUPPORT DEVICES OR SYSTEMS ARE NOT AUTHORIZED. AOS DOES NOT ASSUME ANY LIABILITY ARISING OUT OF SUCH APPLICATIONS OR USES OF ITS PRODUCTS. AOS RESERVES THE RIGHT TO IMPROVE PRODUCT DESIGN, FUNCTIONS AND RELIABILITY WITHOUT NOTICE.

Rev.1.0: October 2017 www.aosmd.com Page 2 of 6

B. The power dissipation P_D is based on $T_{J(MAX)}$ =150° C, using junction-to-case thermal resistance, and is more useful in setting the upper dissipation limit for cases where additional heatsinking is used.

C. Single pulse width limited by junction temperature $T_{J(\text{MAX})}\text{=}150^{\circ}\,$ C.

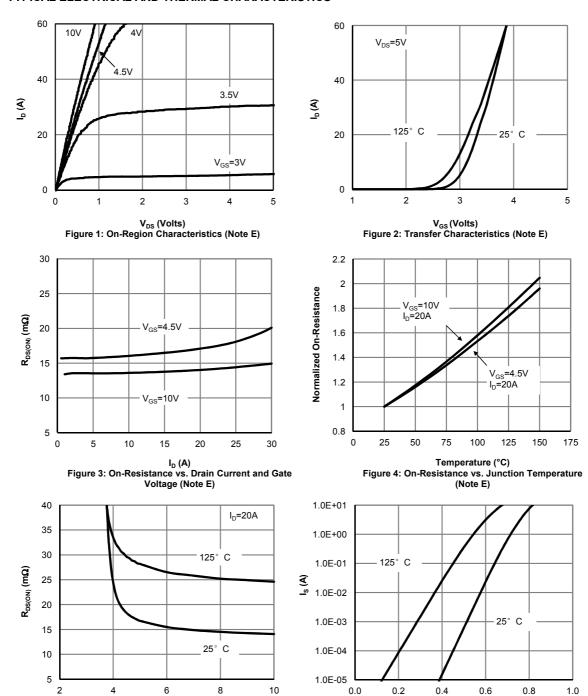
D. The R_{NJA} is the sum of the thermal impedance from junction to case R_{NJC} and case to ambient. E. The static characteristics in Figures 1 to 6 are obtained using <300 μ s pulses, duty cycle 0.5% max. F. These curves are based on the junction-to-case thermal impedance which is measured with the device mounted to a large heatsink, assuming a maximum junction temperature of $T_{J(MAX)}$ =150° C. The SOA curve provides a single pulse rating. G. The maximum current rating is package limited.

H. These tests are performed with the device mounted on 1 in² FR-4 board with 2oz. Copper, in a still air environment with T_A=25° C.



TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

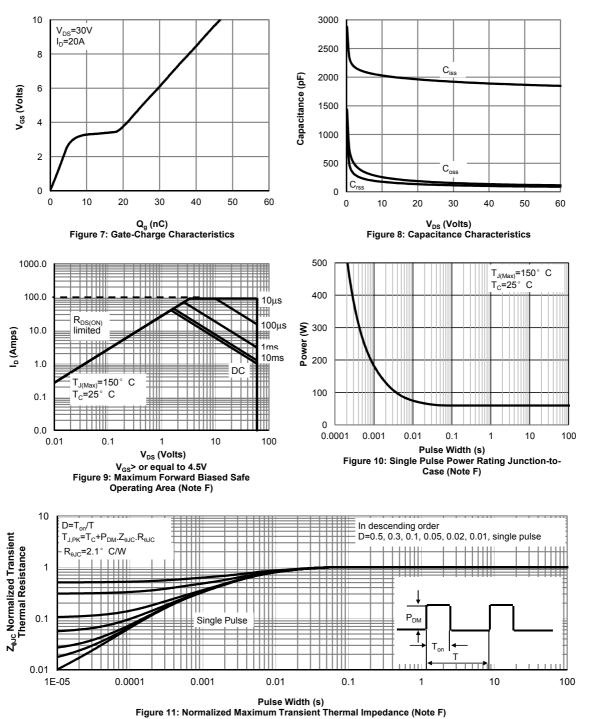
V_{GS} (Volts)
Figure 5: On-Resistance vs. Gate-Source Voltage (Note E)



V_{SD} (Volts) Figure 6: Body-Diode Characteristics (Note E)

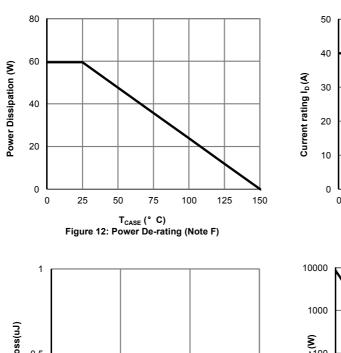


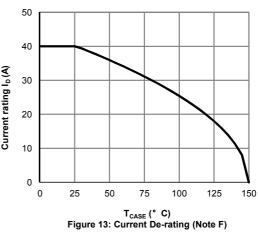
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS

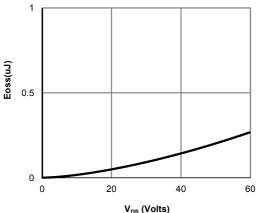


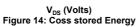


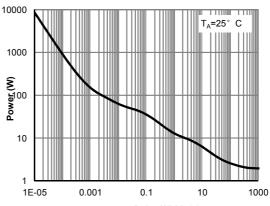
TYPICAL ELECTRICAL AND THERMAL CHARACTERISTICS



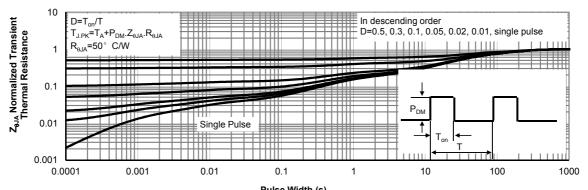








Pulse Width (s)
Figure 15: Single Pulse Power Rating Junction-to-Ambient (Note H)



Pulse Width (s)
Figure 16: Normalized Maximum Transient Thermal Impedance (Note H)

Rev.1.0: October 2017 Page 5 of 6 www.aosmd.com

Figure A: Gate Charge Test Circuit & Waveforms

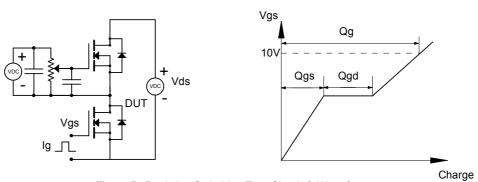


Figure B: Resistive Switching Test Circuit & Waveforms

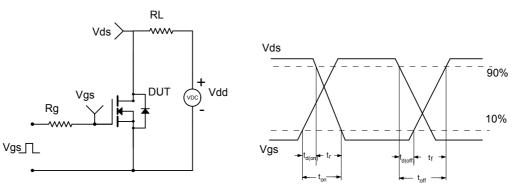


Figure C: Unclamped Inductive Switching (UIS) Test Circuit & Waveforms

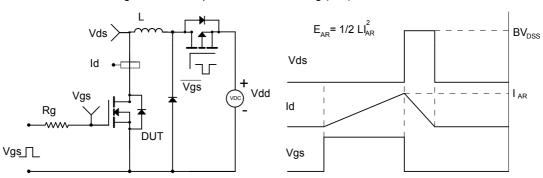
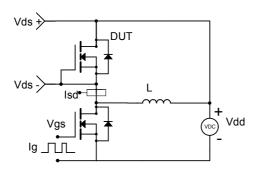
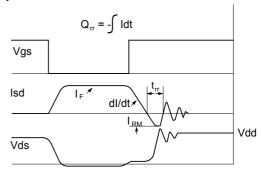


Figure D: Diode Recovery Test Circuit & Waveforms





Rev.1.0: October 2017 www.aosmd.com Page 6 of 6